3.3 V 16-bit transparent D-type latch with 30  $\Omega$  termination resistors; 3-state

Rev. 2 — 1 October 2018

**Product data sheet** 

## 1. General description

The 74LVT162373 is a high-performance BiCMOS product designed for  $V_{CC}$  operation at 3.3 V.

This device is a 16-bit transparent D-type latch with non-inverting 3-state bus compatible outputs. The device can be used as two 8-bit latches or one 16-bit latch. When latch enable (LE) input is HIGH, the Q outputs follow the date (D) inputs. When latch enable is taken LOW, the Q outputs are latched at the levels of the D inputs one setup time prior to the HIGH-to-LOW transition.

The 74LVT162373 is designed with 30  $\Omega$  series resistance in both the HIGH-state and LOW-state of the output. This design reduces the noise in applications such as memory address drivers, clock drivers and bus receivers and transmitters.

## 2. Features and benefits

- 16-bit transparent latch
- 3-state buffers
- Output capability: +12 mA/-12 mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5 V supply
- · Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Outputs include series resistance of 30 Ω making external termination resistors unnecessary
- Power-up reset
- Power-up 3-state
- No bus current loading when output is tied to 5 V bus
- Latch-up protection:
  - JESD78B Class II exceeds 500 mA
- ESD protection:
  - HBM: JESD22-A114F exceeds 2000 V
  - MM: JESD22-A115-A exceeds 200 V

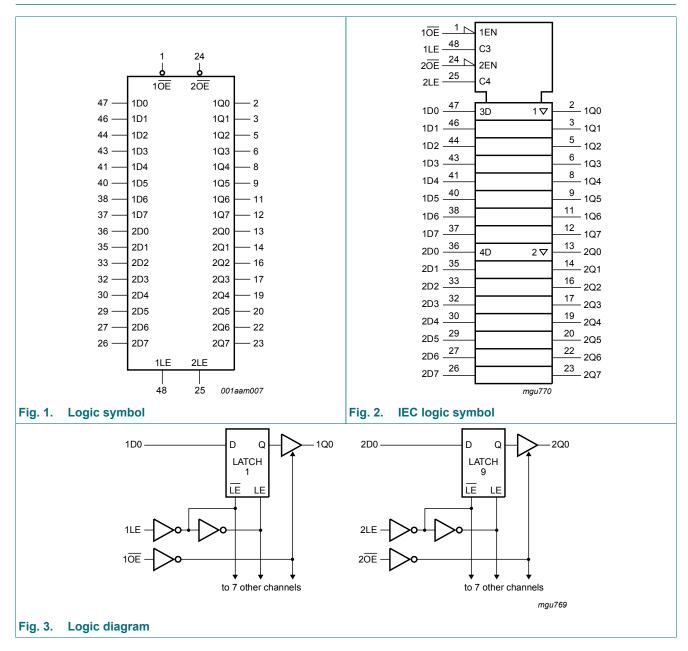
## 3. Ordering information

#### Table 1. Ordering information

Type number	Package	kage						
	Temperature range	Name	Description	Version				
74LVT162373DGG	-40 °C to +85 °C		plastic thin shrink small outline package; 48 leads; body width 6.1 mm	SOT362-1				

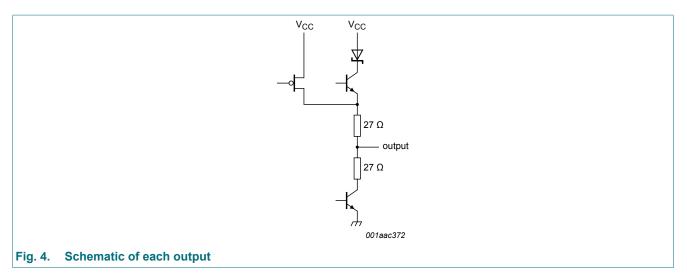
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## 4. Functional diagram



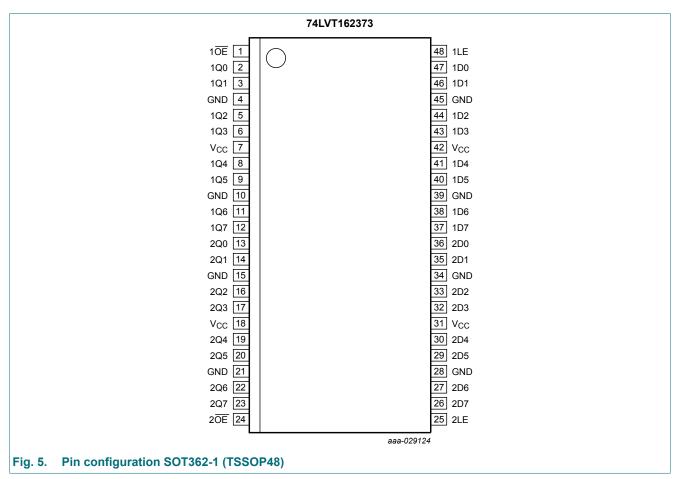
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## 5. Pinning information

### 5.1. Pinning



74LVT162373

#### 5.2. Pin description

#### Table 2. Pin description

Symbol	Pin	Description
1D0, 1D1, 1D2, 1D3, 1D4, 1D5, 1D6, 1D7	47, 46, 44, 43, 41, 40, 38, 37	data inputs
2D0, 2D1, 2D2, 2D3, 2D4, 2D5, 2D6, 2D7	36, 35, 33, 32, 30, 29, 27, 26	data inputs
1Q0, 1Q1, 1Q2, 1Q3, 1Q4, 1Q5, 1Q6, 1Q7	2, 3, 5, 6, 8, 9, 11, 12	data outputs
2Q0, 2Q1, 2Q2, 2Q3, 2Q4, 2Q5, 2Q6, 2Q7	13, 14, 16, 17, 19, 20, 22, 23	data outputs
10E, 20E	1, 24	output enable inputs (active LOW)
1LE, 2LE	48, 25	Latch Enable inputs (active HIGH)
GND	4, 10, 15, 21, 28, 34, 39, 45	ground (0 V)
V <sub>CC</sub>	7, 18, 31, 42	supply voltage

## 6. Functional description

#### Table 3. Function table [1]

Operating mode	Inputs		Internal	Outputs	
	nOE	nLE	nDn	latches	nQn
enable and read register (transparent mode)	L	Н	L	L	L
	L	Н	Н	Н	Н
latch and read register	L	↓	I	L	L
	L	$\downarrow$	h	Н	Н
Hold	L	L	Х	NC	NC
Latch register and disable outputs	Н	L	Х	NC	Z
	Н	Н	nDn	nDn	Z

[1] H = HIGH voltage level;

L = LOW voltage level;

 $\downarrow$  = HIGH-to-LOW LE transition;

h = HIGH voltage level one set-up time prior to the HIGH-to-LOW LE transition;

I = LOW voltage level one set-up time prior to the HIGH-to-LOW LE transition;

X = don't care;

NC = No change;

Z = high-impedance OFF-state.

## 7. Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC</sub>	supply voltage			-0.5	+4.6	V
VI	input voltage		[1]	-0.5	+7.0	V
Vo	output voltage	output in OFF-state or HIGH-state	[1]	-0.5	+7.0	V
I <sub>IK</sub>	input clamping current	V <sub>1</sub> < 0 V		-50	-	mA
I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0 V		-50	-	mA
I <sub>O</sub>	output current	output in LOW-state		-	128	mA
		output in HIGH-state		-64	-	mA
T <sub>stg</sub>	storage temperature			-65	+150	°C

Symbol	Parameter	Conditions	Min	Max	Unit
Тj	junction temperature	[2]	-	150	°C

The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
 The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

## 8. Recommended operating conditions

#### Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage		2.7	-	3.6	V
VI	input voltage		0	-	5.5	V
Δt/ΔV	input transition rise and fall rate	outputs enabled	-	-	10	ns/V
T <sub>amb</sub>	ambient temperature	in free-air	-40	+25	+85	°C

## 9. Static characteristics

#### Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
V <sub>IK</sub>	input clamping voltage	V <sub>CC</sub> = 2.7 V; I <sub>IK</sub> = -18 mA	-	-0.85	-1.2	V
VIH	HIGH-level input voltage		2.0	-	-	V
V <sub>IL</sub>	LOW-level input voltage		-	-	0.8	V
V <sub>OH</sub>	HIGH-level output voltage	V <sub>CC</sub> = 3.0 V; I <sub>OH</sub> = -12 mA	2.0	-	-	V
V <sub>OL</sub>	LOW-level output voltage	V <sub>CC</sub> = 3.0 V; I <sub>OL</sub> = 16 mA	-	-	0.8	V
I <sub>OH</sub>	HIGH-level output current		-	-	-12	mA
I <sub>OL</sub>	LOW-level output current		-	-	12	mA
V <sub>OL(pu)</sub>	power-up LOW-level output voltage	$V_{CC}$ = 3.6 V; I <sub>O</sub> = 1 mA; V <sub>I</sub> = V <sub>CC</sub> or GND [2]	-	0.1	0.55	V
l <sub>l</sub>	input leakage current	all input pins				
		V <sub>CC</sub> = 0 V or 3.6 V; V <sub>I</sub> = 5.5 V	-	0.4	10	μA
		control pins				
		$V_{CC}$ = 3.6 V; $V_{I}$ = $V_{CC}$ or GND	-	0.1	±1	μA
		data pins; $V_{CC}$ = 3.6 V [3]				
		V <sub>I</sub> = V <sub>CC</sub>	-	0.1	1	μA
		$V_1 = 0 V$	-	-0.4	-5	μA
I <sub>OFF</sub>	power-off leakage current	$V_{CC}$ = 0 V; V <sub>I</sub> or V <sub>O</sub> = 0 V to 4.5 V	-	0.1	±100	μA
I <sub>BHL</sub>	bus hold LOW current	nDn inputs; V <sub>CC</sub> = 3 V; V <sub>I</sub> = 0.8 V	75	135	-	μA
I <sub>BHH</sub>	bus hold HIGH current	nDn inputs; $V_{CC}$ = 3 V; $V_{I}$ = 2.0 V	-75	-135	-	μA
I <sub>BHLO</sub>	bus hold LOW overdrive current	nDn inputs; $V_{CC}$ = 3.6 V; $V_I$ = 0 V to 3.6 V [4]	500	-	-	μA
I <sub>BHHO</sub>	bus hold HIGH overdrive current	nDn inputs; $V_{CC}$ = 3.6 V; $V_I$ = 0 V to 3.6 V [4]	-	-	-500	μA
I <sub>CEX</sub>	output high leakage current	output in HIGH-state when V <sub>O</sub> > V <sub>CC</sub> ; V <sub>O</sub> = 5.5 V; V <sub>CC</sub> = 3.0 V	-	50	125	μA
I <sub>O(pu/pd)</sub>	power-up/power-down output current	$V_{CC} \le 1.2 \text{ V}; V_0 = 0.5 \text{ V to } V_{CC};$ [5] V <sub>I</sub> = GND or V <sub>CC</sub> ; nOE = don't care	-	1	±100	μA

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
I <sub>OZ</sub>	OFF-state output current	$V_{CC}$ = 3.6 V; $V_{I}$ = $V_{IH}$ or $V_{IL}$					
		V <sub>O</sub> = 3.0 V		-	0.5	5	μA
		V <sub>O</sub> = 0.5 V		-	0.5	-5	μA
I <sub>CC</sub>	supply current	$V_{CC}$ = 3.6 V; $V_I$ = GND or $V_{CC}$ ; $I_O$ = 0 A					
		outputs HIGH		-	0.07	0.12	mA
		outputs LOW		-	4.0	6	mA
		outputs disabled	[6]	-	0.07	0.12	mA
ΔI <sub>CC</sub>	additional supply current	per input pin; $V_{CC}$ = 3 V to 3.6 V; one input at $V_{CC}$ - 0.6 V; other inputs at $V_{CC}$ or GND	[7]	-	0.1	0.2	mA
CI	input capacitance	V <sub>I</sub> = 0 V or 3.0 V		-	3	-	pF
Co	output capacitance	Outputs disabled; $V_0 = 0 V \text{ or } 3.0 V$		-	9	-	pF

[1]

Typical values are at V<sub>CC</sub> = 3.3 V and T<sub>amb</sub> = 25 °C. For valid test results, data must not be loaded into the latches after applying power. [2]

[3] Unused pins at V<sub>CC</sub> or GND.

This is the bus hold overdrive current required to force the input to the opposite logic state. [4]

[5] This parameter is valid for any V<sub>CC</sub> between 0 V and 1.2 V with a transition time of up to 10 ms. From V<sub>CC</sub> = 1.2 V to V<sub>CC</sub> = 3.0 V to 3.6 V a transition time of 100  $\mu$ s is permitted. This parameter is valid for T<sub>amb</sub> = 25 °C only.

 $I_{CC}$  with outputs disabled is measured with outputs pulled to  $V_{CC}$  or GND. [6]

This is the increase in supply current for each input at the specified voltage level other than V<sub>CC</sub> or GND. [7]

## 10. Dynamic characteristics

#### Table 7. Dynamic characteristics

At recommended operating conditions; Voltages are referenced to GND (ground = 0 V); for test circuit see Fig. 10.

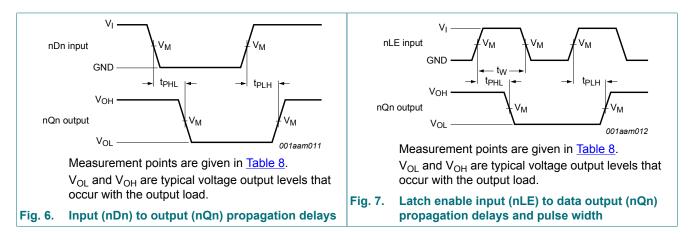
Symbol	Parameter	Conditions	Min	Typ[1]	Мах	Unit
t <sub>PLH</sub>	LOW to HIGH	nDn to nQn; see Fig. 6				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	5.1	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	0.5	2.5	4.6	ns
t <sub>PHL</sub>	HIGH to LOW	nDn to nQn; see Fig. 6				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	4.3	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	0.5	2.5	4.0	ns
t <sub>PLH</sub>	LOW to HIGH	nLE to nQn; see Fig. 7				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	5.8	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	0.5	3.0	5.1	ns
t <sub>PHL</sub>	HIGH to LOW propagation delay	nLE to nQn; see Fig. 7				
		V <sub>CC</sub> = 2.7 V	-	-	4.3	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	0.5	3.0	4.6	ns
t <sub>PZH</sub>	OFF-state to HIGH	nOE to nQn; see Fig. 8				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	6.6	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	0.1	3.5	5.4	ns
t <sub>PZL</sub>	OFF-state to LOW	nOE to nQn; see Fig. 8				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	5.5	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	0.1	3.2	4.9	ns
t <sub>PHZ</sub>	HIGH to OFF-state	nOE to nQn; see Fig. 8				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	5.7	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	0.1	3.5	5.4	ns

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
t <sub>PLZ</sub>	LOW to OFF-state	nOE to nQn; see Fig. 8				
	propagation delay	V <sub>CC</sub> = 2.7 V	-	-	5.0	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	0.1	3.2	5.1	ns
t <sub>su(H)</sub>	set-up time HIGH	nDn to nLE; see Fig. 9				
		V <sub>CC</sub> = 2.7 V	1.0	-	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	1.5	0.1	-	ns
t <sub>su(L)</sub>	set-up time LOW	nDn to nLE; see Fig. 9				
		V <sub>CC</sub> = 2.7 V	2.0	-	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	2.0	0.2	-	ns
t <sub>h(H)</sub>	hold time HIGH	nDn to nLE; see Fig. 9				
		V <sub>CC</sub> = 2.7 V	1.0	-	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	1.0	0	-	ns
t <sub>h(L)</sub>	hold time LOW	nDn to nLE; see Fig. 9				
		V <sub>CC</sub> = 2.7 V	2.0	-	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	1.5	0	-	ns
t <sub>WH</sub>	pulse width HIGH	nLE; see Fig. 7				
		V <sub>CC</sub> = 2.7 V	1.5	-	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	1.5	0.5	-	ns

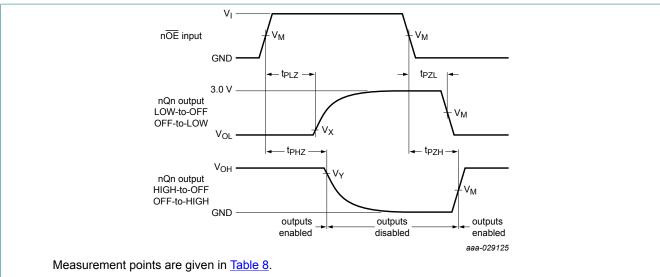
#### 3.3 V 16-bit transparent D-type latch with 30 $\Omega$ termination resistors; 3-state

[1] Typical values are at V<sub>CC</sub> = 3.3 V and T<sub>amb</sub> = 25 °C.

#### 10.1. Waveforms and test circuit

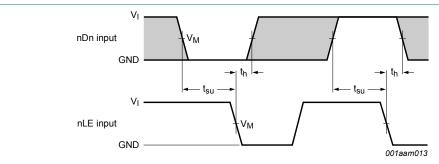


#### 3.3 V 16-bit transparent D-type latch with 30 $\Omega$ termination resistors; 3-state



 $V_{OL}$  and  $V_{OH}$  are typical voltage output levels that occur with the output load.

#### Fig. 8. OFF-state to HIGH or LOW and HIGH or LOW to OFF-state propagation delays



Measurement points are given in Table 8.

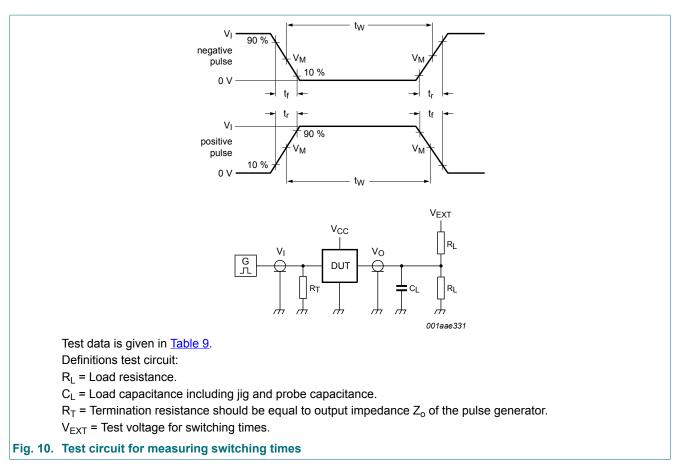
The shaded areas indicate when the input is permitted to change for predictable output performance.

#### Fig. 9. Input (nDn) to output (nLE) data set-up and hold times

#### Table 8. Measurement points

Input		Output			
VI	V <sub>M</sub>	V <sub>M</sub>	V <sub>X</sub>	V <sub>Y</sub>	
2.7 V	1.5 V	1.5 V	V <sub>OL</sub> + 0.3 V	V <sub>OH</sub> - 0.3 V	

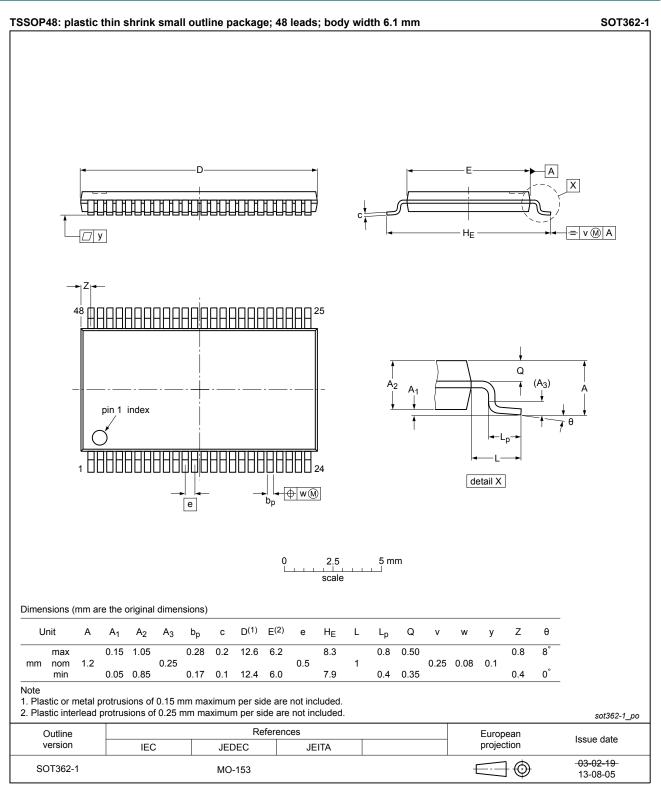
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#### Table 9. Test data

Input			Load		V <sub>EXT</sub>			
V <sub>1</sub>		CL	RL	t <sub>PHZ</sub> , t <sub>PZH</sub> t <sub>PLZ</sub> , t <sub>PZL</sub> t <sub>PLH</sub> ,		t <sub>PLH</sub> , t <sub>PHL</sub>		
2.7 V	≤ 10 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	GND	6 V	open

## **11. Package outline**



#### Fig. 11. Package outline SOT362-1 (TSSOP48)

74LVT162373

## 12. Abbreviations

Table 10. Abbreviations				
Acronym	Description			
BiCMOS	Bipolar Complementary Metal Oxide Semiconductor			
DUT	Device Under Test			
ESD	ElectroStatic Discharge			
MIL	Military			
MM	Machine Model			
TTL	Transistor-Transistor Logic			

## 13. Revision history

#### Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
74LVT162373 v.2	20181001	Product data sheet	-	74LVT162373 v.1	
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the identity guidelines of Nexperia.</li> <li>Legal texts have been adapted to the new company name where appropriate.</li> <li>Type number 74LVT162373DL (SOT370-1) removed.</li> </ul>				
74LVT162373 v.1	19990923	Product specification	-	-	

## 14. Legal information

#### Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

 Please consult the most recently issued document before initiating or completing a design.

- [2] The term 'short data sheet' is explained in section "Definitions".
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